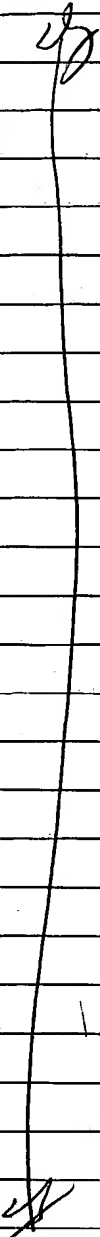
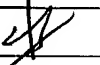
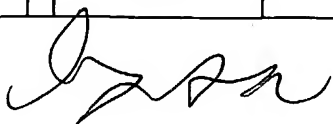
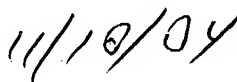


Atty. Docket No.: 00014DIV (3600-267-02)			Application No.:		Unassigned		
Applicant:		RAO, deceased, <i>et al.</i>					
Filing Date: November 25, 2003			Group Art Unit:		Unassigned		
U.S. PATENT DOCUMENTS							
Examiner Initial*	Document Number	Date	Name	Class	Sub Class	Filing Date If Appropriate	
	RE 32,260	10/07/1986	Fry	75	230		
	3,427,132	02/11/1969	Goon	23	204		
	3,723,838	03/27/1973	Kumagai	317	258		
	4,423,004	12/27/1983	Ross	419	35		
	4,544,403	10/01/1985	Schiele et al.	75	0.5 AB		
	4,805,074	02/14/1989	Harakawa et al.	361	525		
	4,954,169	09/04/1990	Behrens	75	228		
	4,968,481	11/06/1990	Rerat	419	23		
	5,211,741	05/18/1993	Fife	75	255		
	5,245,514	09/14/1993	Fife et al.	361	529		
	5,314,675	05/24/1994	Dubots et al.	424	344		
	5,412,533	05/02/1995	Murayama et al.	361	528		
	5,448,447	09/05/1995	Hongju Chang	361	528		
	5,560,761	10/01/1996	Hiroo Naito	75	255		
	5,605,561	02/25/1997	Iwabuchi et al.	75	364		
	5,825,611	10/20/1998	Pozdeev	361	503		
	6,051,044	04/18/2000	Fife	75	229		
	6,115,235	09/05/2000	Naito	361	303		
	6,136,062	10/24/2000	Loffelholz et al.	75	369		
	6,171,363 B1	01/09/2001	Shekhter et al.	75	369		
	6,185,090 B1	02/06/2001	Pozdeev-Freeman	361	524		
	6,193,779 B1	02/27/2001	Reichert et al.	75	343		
	6,212,065 B1	04/03/2001	Pozdeev-Freeman et al.	367	528		
	6,215,652 B1	04/10/2001	Yoshida et al.	631	524		
		6,423,110	07-2002	Natio et al.	75	232	
	FOREIGN PATENT DOCUMENTS						
		Document Number	Date	Country	Class	Sub Class	Translation Yes or No

	DE 19831280	01/20/2000	GERMANY			ABSTRACT
	EP 0 282 291 A2	09/14/1988	EUROPE			
	EP 0 402 687 B1	12/19/1990	EUROPE			ABSTRACT
	EP 0 665 302 A2	08/02/1995	EUROPE			
	EP 0 953 847 A1	11/03/1999	EUROPE			ABSTRACT
	EP 0 984 469 A2	03/08/2000	EUROPE			
	EP 0 984 470 A2	03/08/2000	EUROPE			
	WO 00/08662 A1	02/17/2000	WIPO			Full English Translated Version
	WO 00/49633	08/24/2000	WIPO			ABSTRACT
	WO 01/06525	01/25/2001	WIPO			ABSTRACT
	WO 01/12364	02/22/2001	WIPO			ABSTRACT
	WO 01/64374 A2	09/07/2001	WIPO			
	WO 98/37249 A1	08/27/1998	WIPO			Full English Translated Version
	WO 99/57739	11/11/1999	WIPO			
WO 99/61184	12/02/1999	WIPO				
	WO 00/36617 A1	06/22/2000	JAPAN			Full English Translated Version
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)						
	Terrance B. Tripp, Malcolm D. Shaw, and Bonnie Cox, "The Effects of Nitrogen on The Properties of Anodic Oxide Films on Tantalum," Pages 317-32, (No Date).					
	Terrance B. Tripp, Richard M. Creasi, and Bonnie Cox, "Tantalum Nitride: A New Substrate For Solid Electrolyte Capacitors," Pages 256-262, (March 2000).					
	W.A. Seriak, L. Schechter, T.B. Tripp, L.L. Lanin, K. Reichert, O. Thomas, and J. Vieregge, "A New Material for Capacitors: Niobium," Pages 82-85, (March 2000).					
	International Search Report for PCT/US 01/06449, mailed on September 13, 2001.					
Examiner			Date Considered			
*Examiner:	Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.					
Form PTO 1449			Patent and Trademark Office - U.S. Department of Commerce			